


<b>Search Notes</b> 	<b>Application/Control No.</b> 10631205	<b>Applicant(s)/Patent Under Reexamination</b> CHAUVEL ET AL.
	<b>Examiner</b> Rutz, Jared I	<b>Art Unit</b> 2187

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor search in EAST	10/28/2006	jir
text search in EAST, see search history	10/28/2006	jir
Updated Search in EAST, see search history	2/21/2007	jir

INTERFERENCE SEARCH			
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